

<b>Notice of References Cited</b>	Application/Control No. 10/657,261		Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner Khai M. Nguyen		Art Unit 2617	Page 1 of 1

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*	B	US-6,122,518 A	09-2000	Suda, Koji	455/450
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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